

RF Power Field Effect Transistors

N-Channel Enhancement-Mode Lateral MOSFETs

Designed for base station applications with wide instantaneous bandwidth requirements covering frequencies from 2300 to 2400 MHz.

- Typical Doherty Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Volts, $I_{DQA} = 600$ mA, $V_{GSB} = 1.2$ Vdc, $P_{out} = 30$ Watts Avg., IQ Magnitude Clipping, Channel Bandwidth = 3.84 MHz, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)
2300 MHz	13.9	37.1	7.9	-31.0
2350 MHz	14.1	38.3	7.7	-32.2
2400 MHz	13.8	38.3	7.4	-33.1

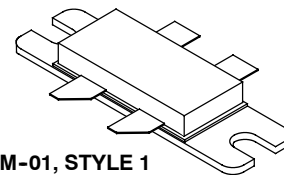
- Capable of Handling 10:1 VSWR, @ 30 Vdc, 2350 MHz, 144 Watts CW ⁽¹⁾ Output Power (3 dB Input Overdrive from Rated P_{out})
- Typical P_{out} @ 3 dB Compression Point ≈ 190 Watts ⁽²⁾

Features

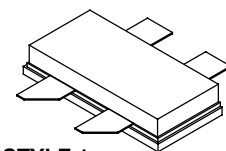
- Designed for Wide Instantaneous Bandwidth Applications
- Designed for Wideband Applications that Require 100 MHz Signal Bandwidth
- Production Tested in a Symmetrical Doherty Configuration
- 100% PAR Tested for Guaranteed Output Power Capability
- Characterized with Large-Signal Load-Pull Parameters and Common Source S-Parameters
- Internally Matched for Ease of Use
- Integrated ESD Protection
- Greater Negative Gate-Source Voltage Range for Improved Class C Operation
- Designed for Digital Predistortion Error Correction Systems
- NI-780-4 in Tape and Reel. R3 Suffix = 250 Units, 56 mm Tape Width, 13 inch Reel. For R5 Tape and Reel option, see p. 14.
- NI-780S-4 in Tape and Reel. R3 Suffix = 250 Units, 32 mm Tape Width, 13 inch Reel. For R5 Tape and Reel option, see p. 14.

MRF8P23160WHR3
MRF8P23160WHSR3

2300-2400 MHz, 30 W AVG., 28 V
SINGLE W-CDMA
LATERAL N-CHANNEL
RF POWER MOSFETs



CASE 465M-01, STYLE 1
NI-780-4
MRF8P23160WHR3



CASE 465H-02, STYLE 1
NI-780S-4
MRF8P23160WHSR3

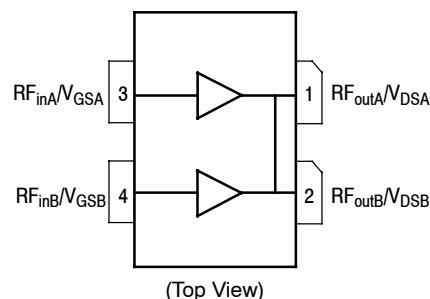


Figure 1. Pin Connections

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature	T_C	125	°C
Operating Junction Temperature ^(3,4)	T_J	225	°C
CW Operation @ $T_C = 25^\circ\text{C}$	CW	129	W
Derate above 25°C		0.48	W/°C

- Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.
- $P_{3dB} = P_{avg} + 7.0$ dB where P_{avg} is the average output power measured using an unclipped W-CDMA single-carrier input signal where output PAR is compressed to 7.0 dB @ 0.01% probability on CCDF.
- Continuous use at maximum temperature will affect MTTF.
- MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (1,2)	Unit
Thermal Resistance, Junction to Case Case Temperature 80°C, 30 W CW, 28 Vdc, I _{DQA} = 600 mA, V _{GGB} = 2.4 Vdc, 2350 MHz Case Temperature 101°C, 130 W CW(3), 28 Vdc, I _{DQA} = 600 mA, V _{GGB} = 2.4 Vdc, 2350 MHz	R _{θJC}	0.69 0.43	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2
Machine Model (per EIA/JESD22-A115)	B
Charge Device Model (per JESD22-C101)	IV

Table 4. Electrical Characteristics (T_A = 25°C unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
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Off Characteristics

Zero Gate Voltage Drain Leakage Current (V _{DS} = 65 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current (V _{DS} = 28 Vdc, V _{GS} = 0 Vdc)	I _{DSS}	—	—	5	μAdc
Gate-Source Leakage Current (V _{GS} = 5 Vdc, V _{DS} = 0 Vdc)	I _{GSS}	—	—	1	μAdc

On Characteristics

Gate Threshold Voltage (V _{DS} = 10 Vdc, I _D = 252 μAdc)	V _{GS(th)}	1.2	1.9	2.7	Vdc
Gate Quiescent Voltage (V _{DS} = 28 Vdc, I _{DA} = 600 mAdc)	V _{GSA(Q)}	—	2.8	—	Vdc
Fixture Gate Quiescent Voltage (4,5) (V _{DD} = 28 Vdc, I _{DA} = 600 mAdc, Measured in Functional Test)	V _{GGA(Q)}	4.1	5.5	7.1	Vdc
Drain-Source On-Voltage (V _{GS} = 10 Vdc, I _D = 3.0 Adc)	V _{DS(on)}	0.1	0.24	0.3	Vdc

Functional Tests (6,7,8) (In Freescale Doherty Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQA} = 600 mA, V_{GGB} = 1.2 Vdc, P_{out} = 30 W Avg., f = 2320 MHz, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured on 3.84 MHz Channel Bandwidth @ ±5 MHz Offset.

Power Gain	G _{ps}	12.0	14.1	15.0	dB
Drain Efficiency	η _D	32.0	36.5	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	7.2	7.8	—	dB
Adjacent Channel Power Ratio	ACPR	—	-32.2	-28.0	dBc

Typical Broadband Performance (6,8) (In Freescale Doherty Test Fixture, 50 ohm system) V_{DD} = 28 Vdc, I_{DQA} = 600 mA, V_{GGB} = 1.2 Vdc, P_{out} = 30 W Avg., Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ ±5 MHz Offset.

Frequency	G _{ps} (dB)	η _D (%)	Output PAR (dB)	ACPR (dBc)
2300 MHz	13.9	37.1	7.9	-31.0
2350 MHz	14.1	38.3	7.7	-32.2
2400 MHz	13.8	38.3	7.4	-33.1

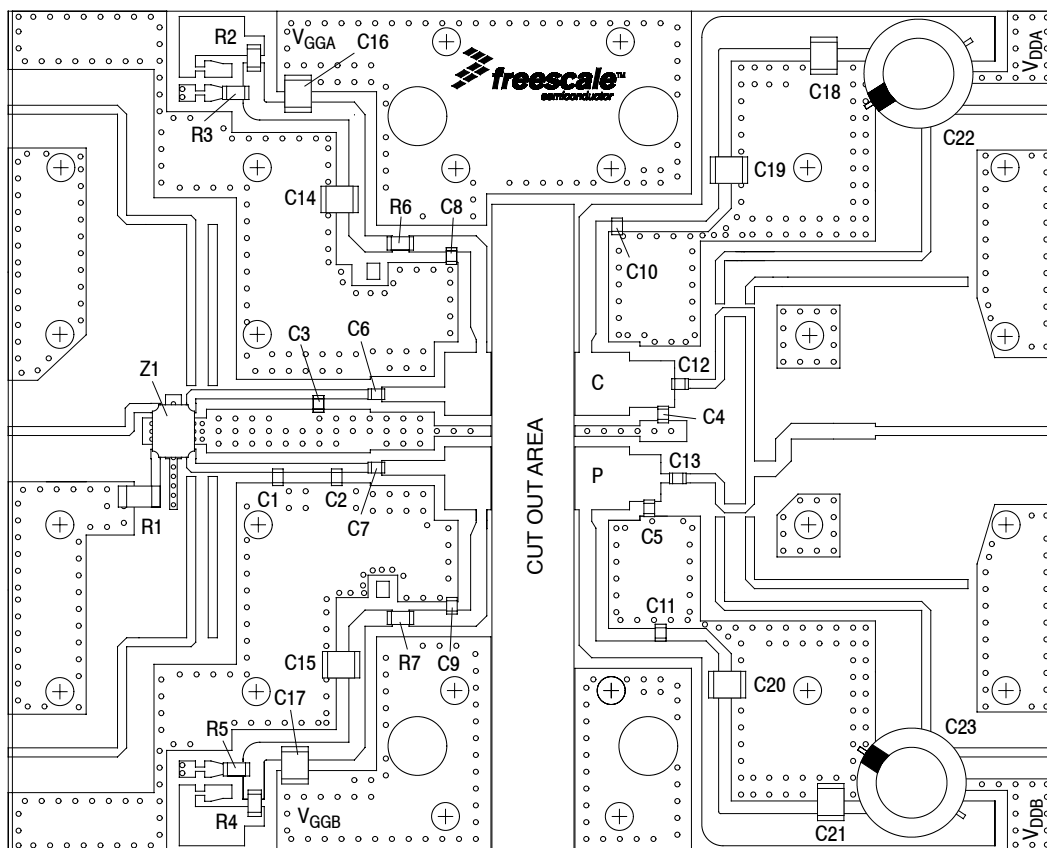
1. MTTF calculator available at <http://www.freescale.com/rf>. Select Software & Tools/Development Tools/Calculators to access MTTF calculators by product.
2. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.freescale.com/rf>. Select Documentation/Application Notes - AN1955.
3. Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.
4. Each side of device measured separately.
5. V_{GG} = 2.0 × V_{GSA(Q)}. Parameter measured on Freescale Test Fixture, due to resistor divider network on the board. Refer to Test Fixture Layout.
6. V_{DDA} and V_{ddb} must be tied together and powered by a single DC power supply.
7. Part internally matched both on input and output.
8. Measurement made with device in a Symmetrical Doherty configuration

(continued)

Table 4. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Typical Performances ⁽¹⁾ (In Freescale Doherty Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQA} = 600\text{ mA}$, $V_{GSB} = 1.2\text{ Vdc}$, 2300–2400 MHz Bandwidth					
P_{out} @ 1 dB Compression Point, CW	P1dB	—	150 ⁽²⁾	—	W
P_{out} @ 3 dB Compression Point ⁽³⁾	P3dB	—	190	—	W
IMD Symmetry @ 28 W PEP, P_{out} where IMD Third Order Intermodulation $\cong 30\text{ dBc}$ (Delta IMD Third Order Intermodulation between Upper and Lower Sidebands $> 2\text{ dB}$)	IMD _{sym}	—	102	—	MHz
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW _{res}	—	150	—	MHz
Gain Flatness in 100 MHz Bandwidth @ $P_{out} = 30\text{ W Avg.}$	G _F	—	0.6	—	dB
Gain Variation over Temperature (-30°C to $+85^\circ\text{C}$)	ΔG	—	0.015	—	dB/ $^\circ\text{C}$
Output Power Variation over Temperature (-30°C to $+85^\circ\text{C}$) ⁽²⁾	ΔP_{1dB}	—	0.017	—	dB/ $^\circ\text{C}$

1. Measurement made with device in a Symmetrical Doherty configuration.
2. Exceeds recommended operating conditions. See CW operation data in Maximum Ratings table.
3. $P_{3dB} = P_{avg} + 7.0\text{ dB}$ where P_{avg} is the average output power measured using an unclipped W-CDMA single-carrier input signal where output PAR is compressed to 7.0 dB @ 0.01% probability on CCDF.



Note: V_{DDA} and V_{ddb} must be tied together and powered by a single DC power supply.

Figure 2. MRF8P23160WHR3(WHSR3) Test Circuit Component Layout

Table 5. MRF8P23160WHR3(WHSR3) Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C4, C5	0.2 pF Chip Capacitors	ATC600F0R2BT250XT	ATC
C2, C3	0.3 pF Chip Capacitors	ATC600F0R3BT250XT	ATC
C6	3.3 pF Chip Capacitor	ATC600F3R3BT250XT	ATC
C7	5.6 pF Chip Capacitor	ATC600F5R6BT250XT	ATC
C8, C9, C12, C13	6.8 pF Chip Capacitors	ATC600F6R8BT250XT	ATC
C10, C11	8.2 pF Chip Capacitors	ATC600F8R2BT250XT	ATC
C14, C15	330 nF, 50 V Chip Capacitors	C3225X7R2A334KT	TDK
C16, C17, C18, C19, C20, C21	10 μ F, 100 V Chip Capacitors	C3225X7R2A106KT	TDK
C22, C23	220 μ F, 100 V Electrolytic Capacitor	EEV-FK2A221M	Panasonic-ECG
R1	50 Ω , 10 W Chip Resistor	CW12010T0050GBK	ATC
R2, R3, R4, R5	390 Ω , 1/4 W Chip Resistors	CRCW1206390FKEA	Vishay
R6, R7	4.75 Ω , 1/4 W Chip Resistors	CRCW12064R75FKEA	Vishay
Z1	2300–2700 MHz 90°, 3 dB Chip Hybrid Coupler	1P603S	Anaren
PCB	0.020", $\epsilon_r = 3.5$	RF35A2	Taconic

TYPICAL CHARACTERISTICS

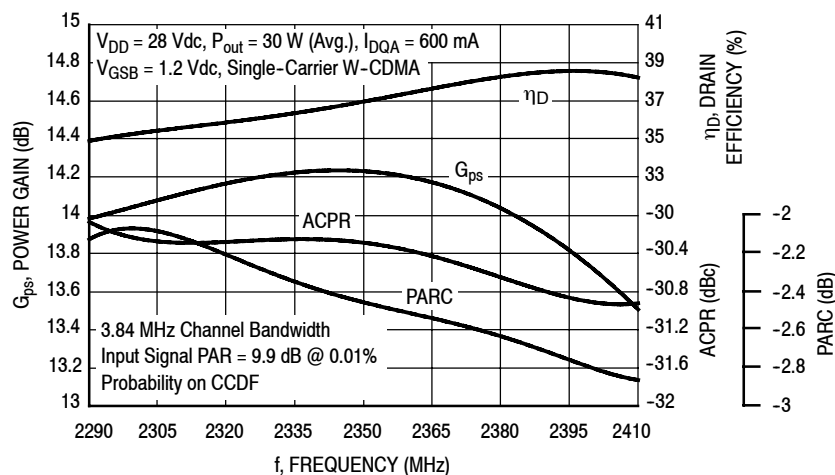


Figure 3. Single-Carrier Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ $P_{out} = 30$ Watts Avg.

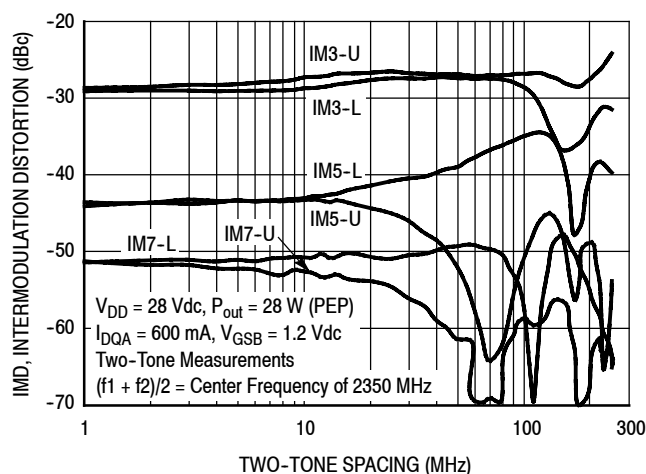


Figure 4. Intermodulation Distortion Products versus Two-Tone Spacing

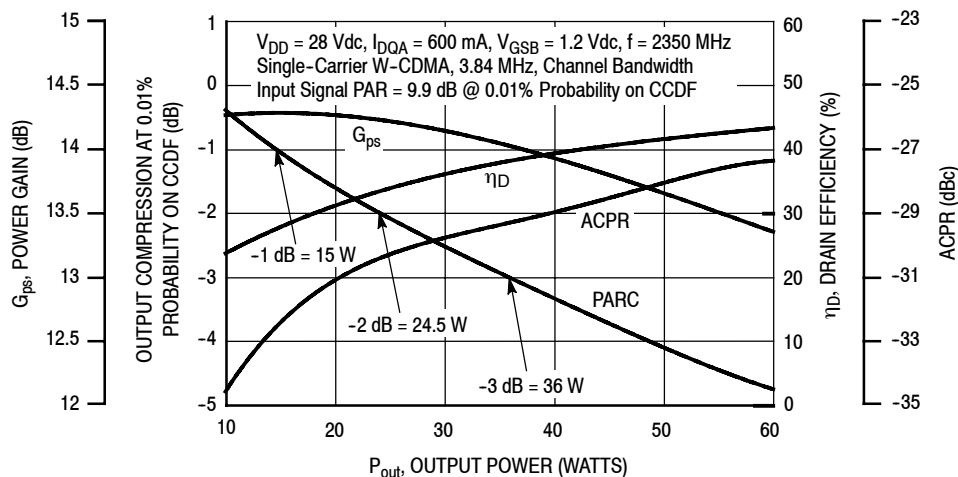


Figure 5. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS

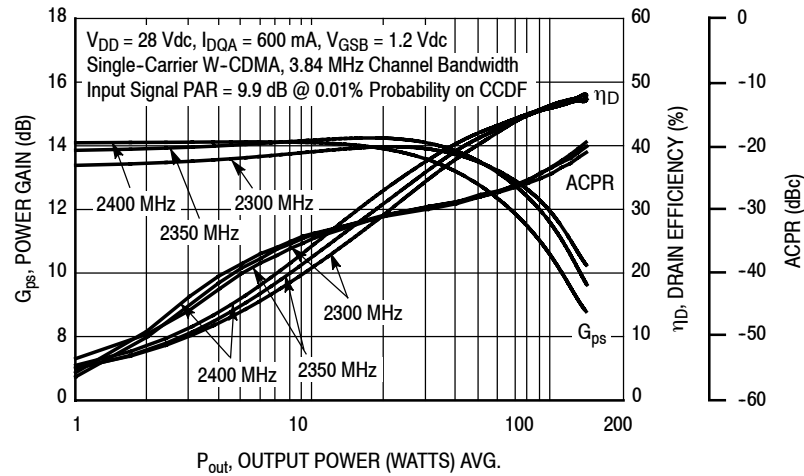


Figure 6. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

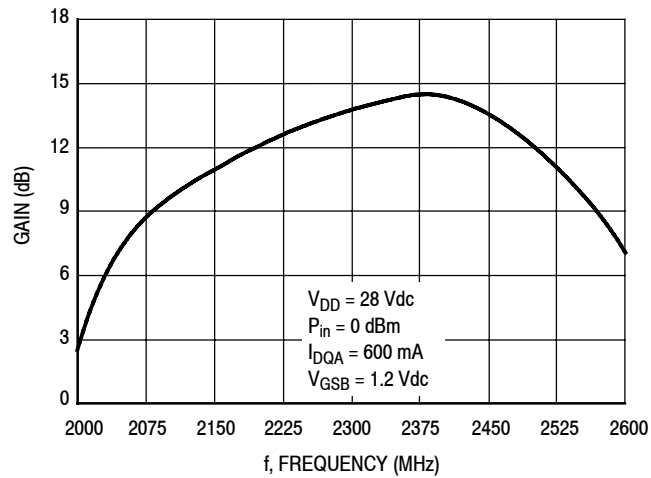


Figure 7. Broadband Frequency Response

W-CDMA TEST SIGNAL

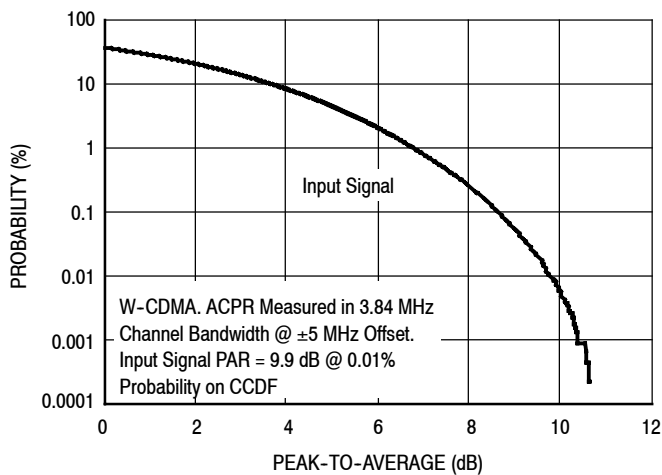


Figure 8. CCDF W-CDMA IQ Magnitude Clipping, Single-Carrier Test Signal

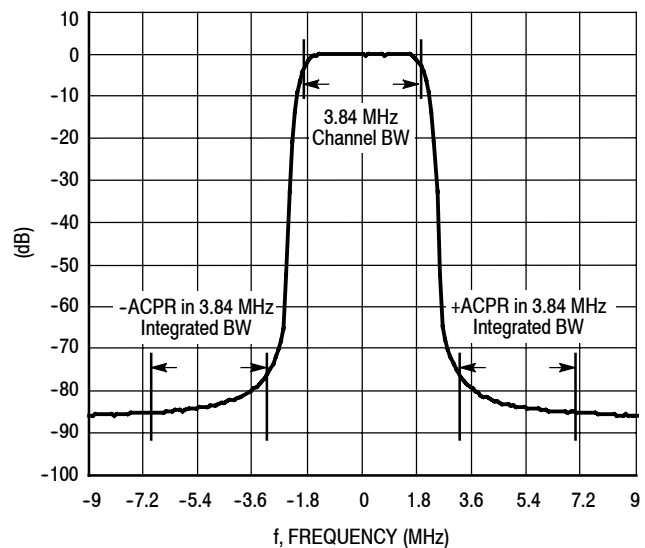


Figure 9. Single-Carrier W-CDMA Spectrum

$V_{DD} = 28 \text{ Vdc}$, $I_{DQA} = 600 \text{ mA}$, Pulsed CW, 10 μsec (on), 10% Duty Cycle

f (MHz)	Z_{source} (Ω)	$Z_{\text{load}}^{(1)}$ (Ω)	Max Output Power					
			P1dB			P3dB		
			(dBm)	(W)	η_D (%)	(dBm)	(W)	η_D (%)
2300	15.8 - j13.8	5.58 - j10.3	49.8	95	47.6	50.8	121	57.1
2350	19.8 - j7.63	5.70 - j10.4	49.7	93	48.2	50.7	119	56.1
2400	16.0 + j0.38	5.96 - j10.5	49.7	92	49.0	50.7	118	55.8

(1) Load impedance for optimum P1dB power.

Z_{source} = Impedance as measured from gate contact to ground.

Z_{load} = Impedance as measured from drain contact to ground.

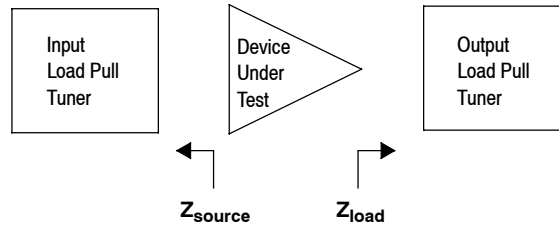


Figure 10. Carrier Side Load Pull Performance — Maximum P1dB Tuning

$V_{DD} = 28 \text{ Vdc}$, $I_{DQA} = 600 \text{ mA}$, Pulsed CW, 10 μsec (on), 10% Duty Cycle

f (MHz)	Z_{source} (Ω)	$Z_{\text{load}}^{(1)}$ (Ω)	Max Drain Efficiency					
			P1dB			P3dB		
			(dBm)	(W)	η_D (%)	(dBm)	(W)	η_D (%)
2300	15.8 - j13.8	6.54 - 4.70	48.3	67	57.1	49.6	91	59.4
2350	19.8 - j7.63	5.70 - 5.65	48.3	68	56.1	49.4	86	58.5
2400	16.0 + j0.38	5.50 - 6.23	48.3	68	55.8	49.7	92	58.0

(1) Load impedance for optimum P1dB efficiency.

Z_{source} = Impedance as measured from gate contact to ground.

Z_{load} = Impedance as measured from drain contact to ground.

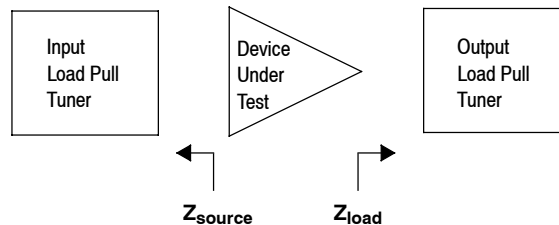
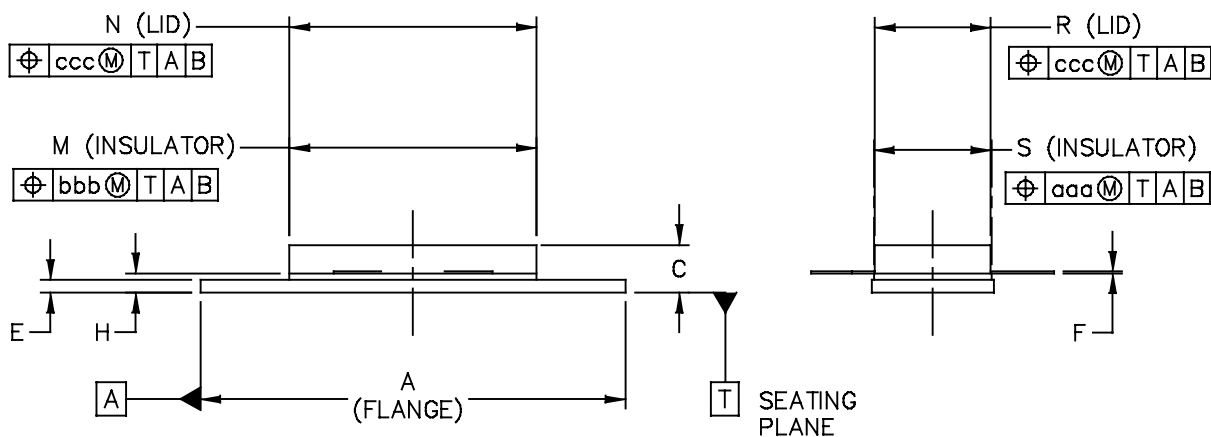
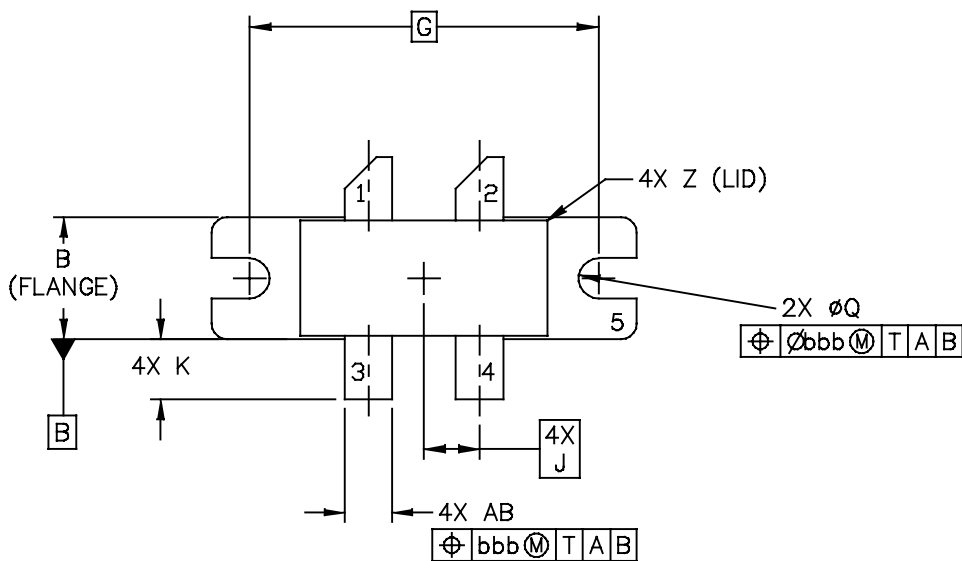


Figure 11. Carrier Side Load Pull Performance — Maximum Drain Efficiency Tuning

PACKAGE DIMENSIONS



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	STANDARD: NON-JEDEC		

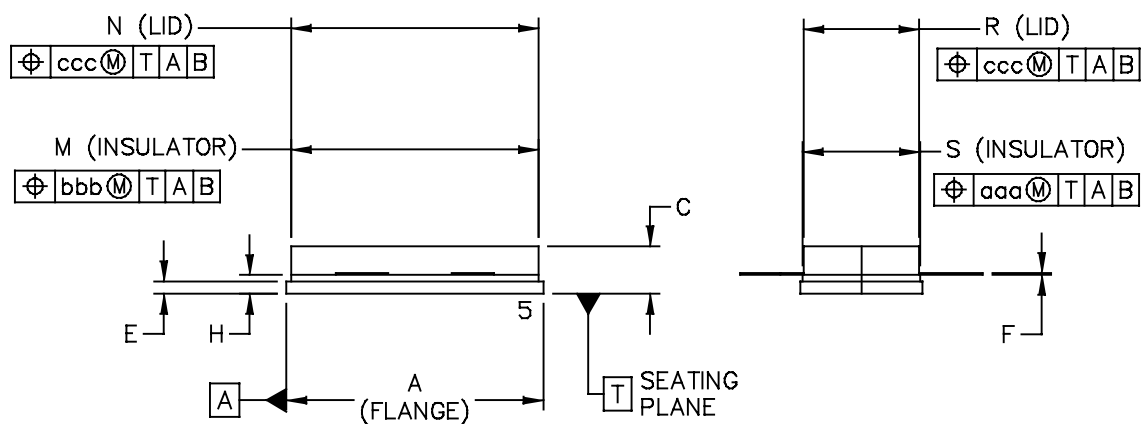
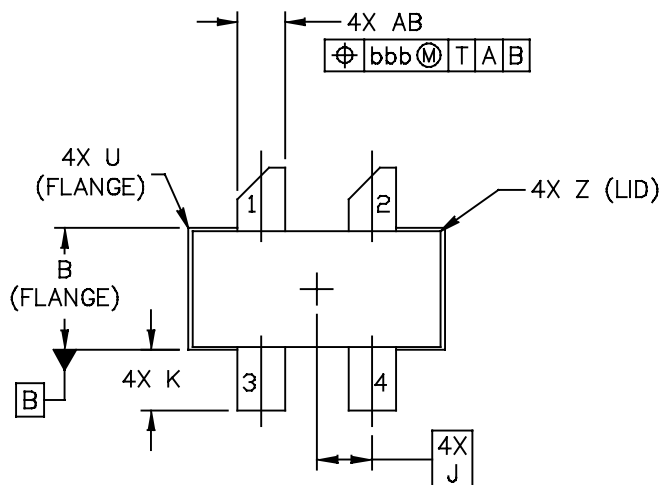
NOTES:

1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M-1994.
2. CONTROLLING DIMENSION: INCH.
3. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN
1. DRAIN
 2. DRAIN
 3. GATE
 4. GATE
 5. SOURCE

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	1.335	1.345	33.91	34.16	R	.365	.375	9.27	9.53
B	.380	.390	9.65	9.91	S	.365	.375	9.27	9.52
C	.125	.170	3.18	4.32	U		.040		1.02
E	.035	.045	0.89	1.14	Z		.030		0.76
F	.003	.006	0.08	0.15	AB	.145	.155	3.68	3.94
G	1.100 BSC		27.94 BSC						
H	.057	.067	1.45	1.7	aaa	.005		0.127	
J	.175 BSC		4.44 BSC		bbb	.010		0.254	
K	.170	.210	4.32	5.33	ccc	.015		0.381	
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
Q	Ø.118	Ø.138	Ø3	Ø3.51					
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2. CONTROLLING DIMENSION: INCH.
3. DELETED
4. DIMENSION H IS MEASURED .030 (0.762) AWAY FROM PACKAGE BODY.

STYLE 1:

- PIN 1. DRAIN
2. DRAIN
3. GATE
4. GATE
5. SOURCE

INCH			MILLIMETER		INCH			MILLIMETER	
DIM	MIN	MAX	MIN	MAX	DIM	MIN	MAX	MIN	MAX
A	.805	.815	20.45	20.7	U		.040		1.02
B	.380	.390	9.65	9.91	Z		.030		0.76
C	.125	.170	3.18	4.32	AB	.145	.155	3.68	— 3.94
E	.035	.045	0.89	1.14					
F	.003	.006	0.08	0.15	aaa		.005		0.127
H	.057	.067	1.45	1.7	bbb		.010		0.254
J	.175 BSC		4.44 BSC		ccc		.015		0.381
K	.170	.210	4.32	5.33					
M	.774	.786	19.61	20.02					
N	.772	.788	19.61	20.02					
R	.365	.375	9.27	9.53					
S	.365	.375	9.27	9.52					
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					STANDARD: NON-JEDEC				

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following documents, software and tools to aid your design process.

Application Notes

- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

For Software and Tools, do a Part Number search at <http://www.freescale.com>, and select the “Part Number” link. Go to the Software & Tools tab on the part’s Product Summary page to download the respective tool.

R5 TAPE AND REEL OPTION

R5 Suffix = 50 Units, 56 mm Tape Width, 13 inch Reel.

The R5 tape and reel option for MRF8P23160WH and MRF8P23160WHS parts will be available for 2 years after release of MRF8P23160WH and MRF8P23160WHS. Freescale Semiconductor, Inc. reserves the right to limit the quantities that will be delivered in the R5 tape and reel option. At the end of the 2 year period customers who have purchased these devices in the R5 tape and reel option will be offered MRF8P23160WH and MRF8P23160WHS in the R3 tape and reel option.

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Dec. 2011	• Initial Release of Data Sheet

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